



SIGC121T120R2C

IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology 200µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- · easy paralleling
- integrated gate resistor

This chip is used for:

power module BSM 75GD120DN2



Applications:

drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC121T120R2C	1200V	75A	11.08 X 11.08 mm ²	sawn on foil	Q67041- A4682-A003

MECHANICAL PARAMETER:

Raster size	11.08 X 11.08			
Emitter pad size	8 x (2.99 x 1.97)			
Gate pad size	1.46 x 0.8			
Area total / active	122.8 / 99.6			
Thickness	200	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	106 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month			



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	103	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	206	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i drametei	Cymbol		min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V _{GE} =0V , I _C =4mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =75A	2.0	2.5	3.0	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=3mA$, $V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			500	μA
Gate-emitter leakage current	I _{GES}	V_{CE} =0V , V_{GE} =30V			480	nA
Integrated gate resistor	R _{Gint}			5		Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Conditions	Value			Unit	
raiametei	Symbol	Conditions	min.	typ.	max.	Ullit
Input capacitance	Ciss	$V_{CE}=25V$,	-	5.1	-	nF
Output capacitance	Coss	$V_{GE}=0V$,	-	0.72	-	
Reverse transfer capacitance	Crss	f=1MHz	-	0.38	-	

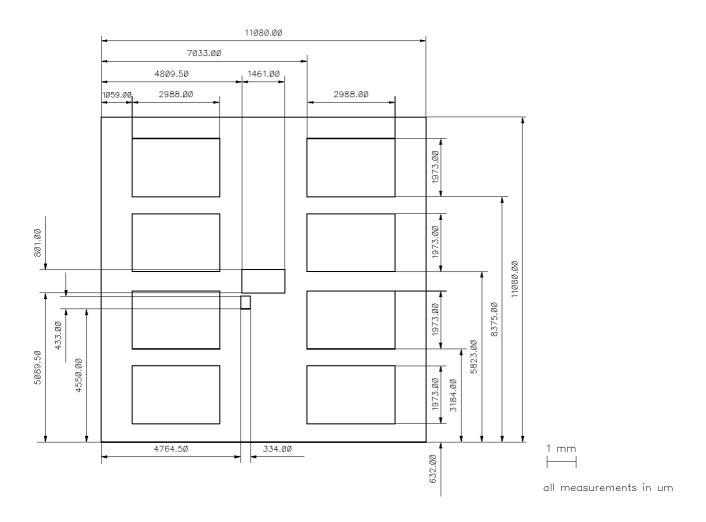
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions	Value			Unit
raidilletei	Symbol		min.	typ.	max.	Onit
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C	-	30	60	ns
Rise time	$t_{\rm r}$	$V_{\rm CC} = 600 \text{V},$	-	70	140	
Turn-off delay time	$t_{d(off)}$	$I_{C} = 75A$, $V_{GE} = +15/-15V$,	-	450	600	
Fall time	t_{f}	$R_{\rm G}$ =15 Ω	-	70	100	



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CHIP DRAWING:





Preliminary

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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	BSM 75GD120DN2	ECONOPACK3
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DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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